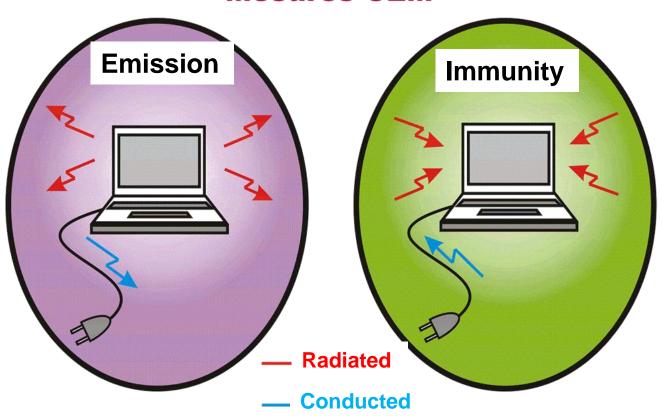




Types of EMC measures



Mesures CEM





Immunity tests



The purpose of immunity tests is to subject a product to a controlled stress that represents the likely range which is mostly dedicated by practical aspects and experience of real-world problems.





Immunity tests

1 – transient phenomena



Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

Performance Criteria B – 'Temporary degradation which is self-

recoverable'

Performance Criteria C – 'Temporary degradation which requires operator intervention'

Performance Criteria D – 'Loss of function which is not recoverable'



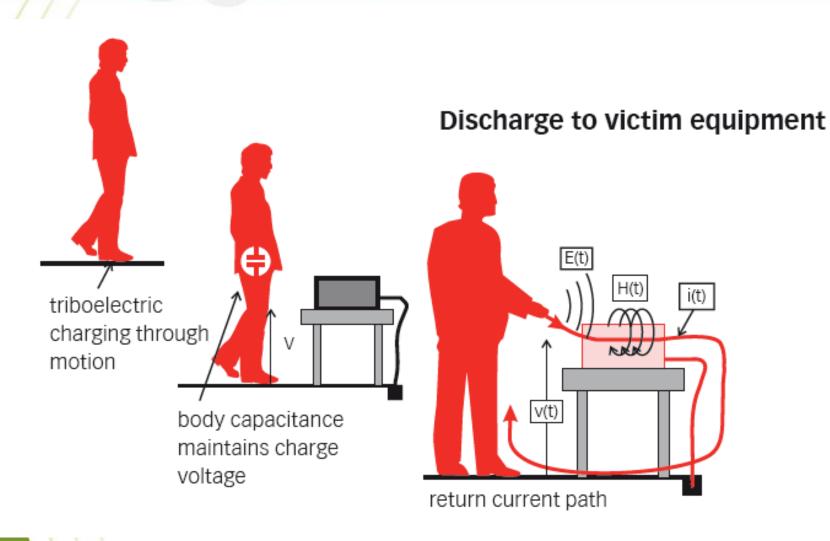


ESD IEC 61000-4-2



Electrostatic Discharge ESD – IEC 61000-4-2







Electrostatic discharge (IEC 61000-4-2)



- Test purpose
- Evaluate the performance of a device submitted to human electric discharge
- Needed instruments:
 - ✓ ESD generator
 - Ground plane (horizontal and vertical)
 - ✓ Isolant surface
 - √ 470 kΩ loads



ESD generator

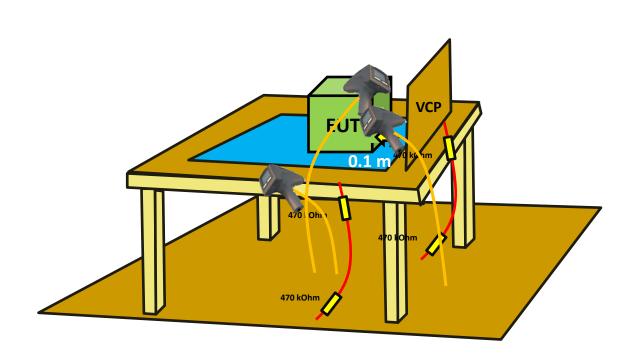






ESD Test setup





Conducting surface

- -1 n!

Dielectrical material

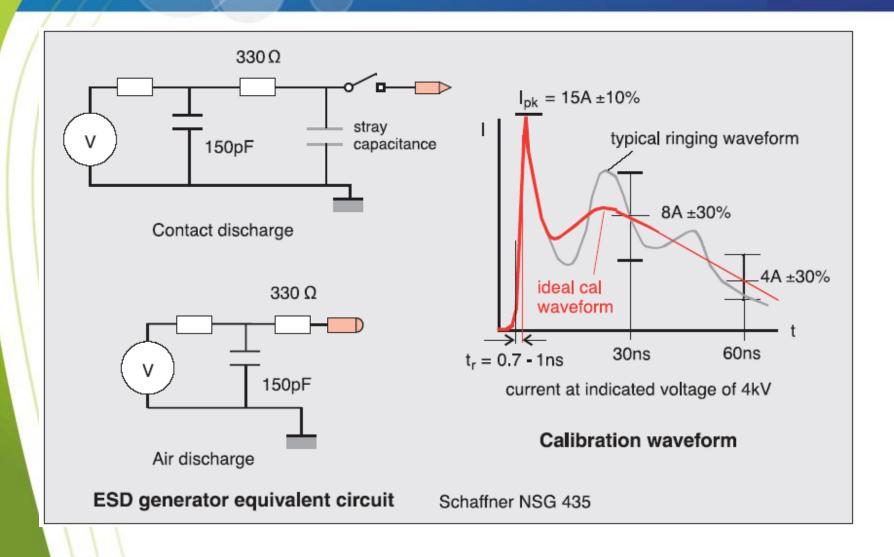


Isolating surface



ESD Waveform







Test levels



Table 1 - Test levels

1a - Contact discharge		1b – Air discharge	
Level	Test voltage kV	Level	Test voltage kV
1	2	1	2
2	4	2	4
3	6	3	8
4	8	4	15
x 1)	Special	x 1)	Speciál

[&]quot;x" is an open level. The level has to be specified in the dedicated equipment specification. If higher voltages than those shown are specified, special rest equipment may be needed.



Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

Performance Criteria B – 'Temporary degradation which is self-

recoverable'

Performance Criteria C – 'Temporary degradation which requires operator intervention'

Performance Criteria D – 'Loss of function which is not recoverable'



Standards calls



Standard	Scope	ESD	EFT-burst	Surge
IEC/EN 61000-6-1: 2001	Residential, commercial & light industrial generic	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power > 10 m, signal and functional earth > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC power input; 0.5 kV L-L & L-E DC power > 10 m, to IEC/EN 61000-4-5
IEC/EN 61000-6-2: 2005	Industrial generic	4 kV contact, 8 kV air to IEC/EN 61000-4-2	2 kV AC power, DC power > 3 m, 1 kV signal and functional earth > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC power; 0.5 kV L-L & L-E DC power connected to a distribution network; 1 kV L-E signal > 30 m, to IEC/EN 61000-4-5
EN 55014-2: 1997 + A1: 2001	Household appliances etc.	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power, signal and control > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC mains, to IEC/EN 61000-4-5
EN 55020: 2002	Broadcast receivers etc.	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power to IEC/EN 61000-4-4	Not required
EN 55024: 1998	Information technology equip- ment	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power, signal and telecom > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC mains, 0.5 kV L-E on DC power with outdoor cables, to IEC/EN 61000-4-5; 1.5 kV 10/700 µs on signal/telecom ports with outdoor cables, to ITU-T K recs.



Discharge Application

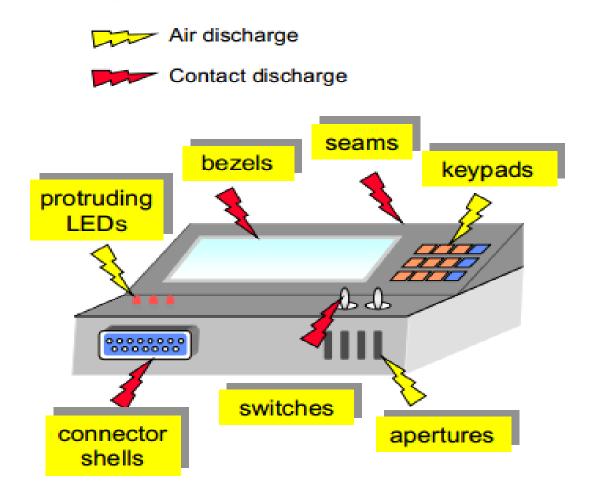


- Application of discharge:
 - ✓ Direct: on the surface of the device under test
 - ✓ Indirect: in the coupling planes
- Types of discharges:
 - ✓ In contact: the conductive surface (head pointed gun)
 - In air: on insolating surfaces (gun head rounded)
- Maximum 1 per second discharge



Choice of discharge points









• The discharge return cable of the ESD generator shall be connected to the ground reference plane. The total length of this cable is in general 2 m.



Fundamental Principals



- In the case of air discharge testing, the climatic conditions shall be within the following ranges:
 - ambient temperature: 15 °C to 35 °C;
 - ✓ relative humidity: 30 % to 60 %;
 - ✓ atmospheric pressure: 86 kPa (860 mbar) to 106 kPa (1 060 mbar).



Execution of the test



- The testing shall be performed by direct and indirect application
- of discharges to the EUT according to a test plan. This should

include:

- representative operating conditions of the EUT;
- whether the EUT should be tested as table-top or floor-standing;



Contact/air discharge



- In the case of contact discharges, the tip of the discharge electrode shall touch the EUT, before the discharge switch is operated.
- In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT.

Link to the standard IEC 61000-4-2



ESD design



Design to avoid ESD problems includes:

- choose circuit configurations that are unresponsive to short transients
- lay out the PCB to minimise induced voltages at critical nodes
- prevent unavoidable discharge transients from coupling
 - into circuits and cables
- design enclosures as far as possible to





EFT IEC 61000-4-4



The EFT phenomenum

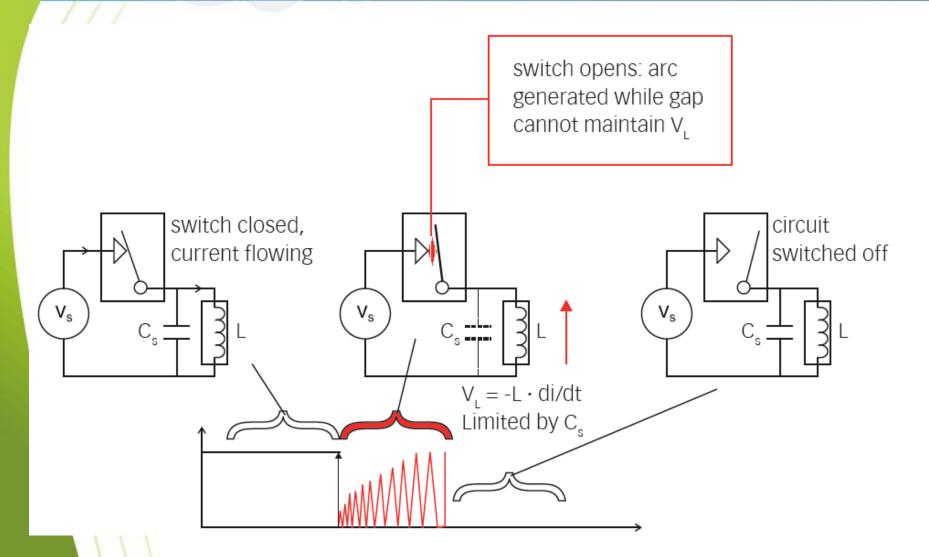


- When a circuit is switched off, the current fl owing through the switch is interrupted more or less instantaneously.
- At the moment of switching there is an infinite di/dt.
- All circuits have some stray inductance associated with
 - the wiring; some types of load, such as motors or
 - solenoids, have considerably more inductance²³



The EFT phenomenum







Electrical fast transients IEC 61000-4-4

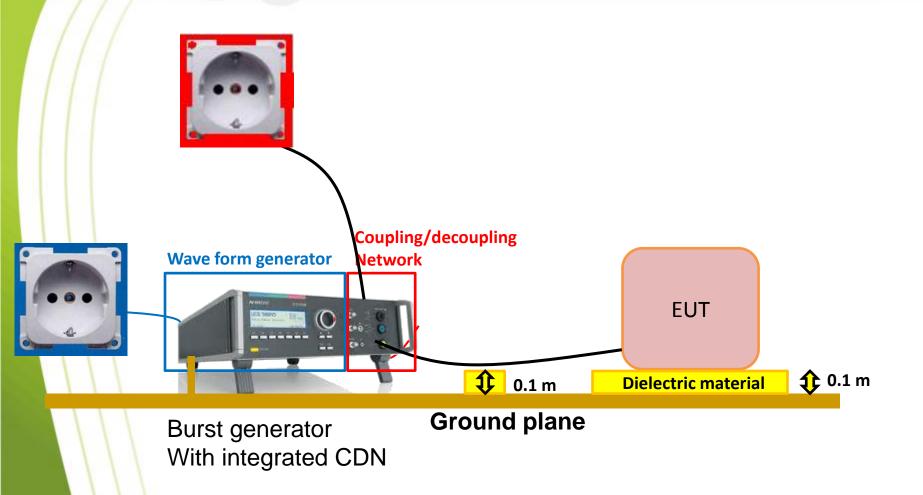


- Purpose of test:
 - Immunity test when subjected to transient disturbances like switching transients.
- Materials needed:
 - ✓ EFT generator
 - Coupling & decoupling device (internal or external)
 - Capacitive coupling clamp for telecom line



Electric Fast Transients EFT – Burst – EN 61000-4-4







Test levels



Open circuit output test voltage and repetition rate of the impulses				
	On power port, PE		On I/O (input/output) signal, data and control ports	
Level	Voltage peak	Repetition rate	Voltage peak	Repetition rate
	kV	kHz	k∨	kHz
1	0,5	5 or 100	0,25	5 or 100
2	1	5 or 100	0,5	5 or 100
3	2	5 or 100	1	5 or 100
4	4	5 or 100	2	5 or 100
X ^a	Special	Special	Special	Special

NOTE 1 Use of 5 kHz repetition rates is traditional; however, 100 kHz is closer to reality. Product committees should determine which frequencies are relevant for specific products or product types.

NOTE 2 With some products, there may be no clear distinction between power ports and I/O ports, in which case it is up to product committees to make this determination for test purposes.

[&]quot;X" is an open level. The level has to be specified in the dedicated equipment specification.



Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

Performance Criteria B – 'Temporary degradation which is self-

recoverable'

Performance Criteria C – 'Temporary degradation which requires operator intervention'

Performance Criteria D – 'Loss of function which is not recoverable'



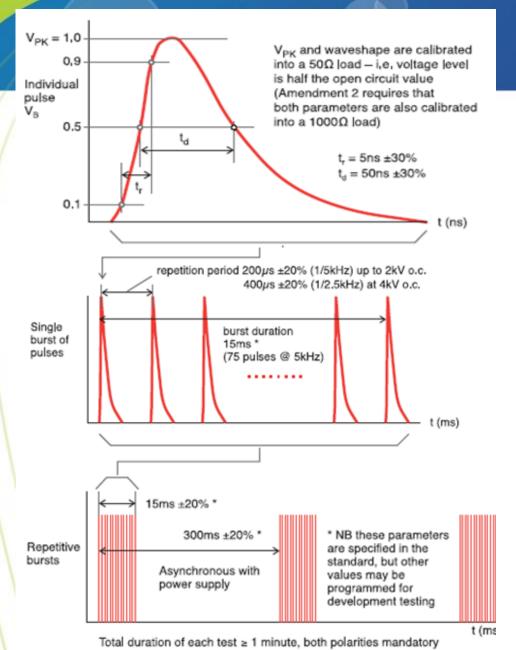
Standards calls



Standard	Scope	ESD	EFT-burst	Surge
IEC/EN 61000-6-1: 2001	Residential, commercial & light industrial generic	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power > 10 m, signal and functional earth > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC power input; 0.5 kV L-L & L-E DC power > 10 m, to IEC/EN 61000-4-5
IEC/EN 61000-6-2: 2005	Industrial generic	4 kV contact, 8 kV air to IEC/EN 61000-4-2	2 kV AC power, DC power > 3 m, 1 kV signal and functional earth > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC power; 0.5 kV L-L & L-E DC power connected to a distribution network; 1 kV L-E signal > 30 m, to IEC/EN 61000-4-5
EN 55014-2: 1997 + A1: 2001	Household appliances etc.	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power, signal and control > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC mains, to IEC/EN 61000-4-5
EN 55020: 2002	Broadcast receivers etc.	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power to IEC/EN 61000-4-4	Not required
EN 55024: 1998	Information technology equip- ment	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power, signal and telecom > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC mains, 0.5 kV L-E on DC power with outdoor cables, to IEC/EN 61000-4-5; 1.5 kV 10/700 µs on signal/telecom ports with outdoor cables, to ITU-T K recs.







EFT wave form



EFT Application



- On each conductor
- For at least 1 min
- polarity + And –
- Test levels and intermediate levels



Test setup



- Table-top equipment : EUT located 0,1 m above the ground plane.
- The test generator and CDN placed directly on, and connected to, the ground plane.
- All cables connected to the EUT shall be placed on the insulation support 0,1 m above the ground reference plane.



Test setup



- Either a direct coupling network or a capacitive clamp shall be used for the application of the test voltages.
- Decoupling networks shall be used to protect auxiliary equipment and public networks.



Test procedure

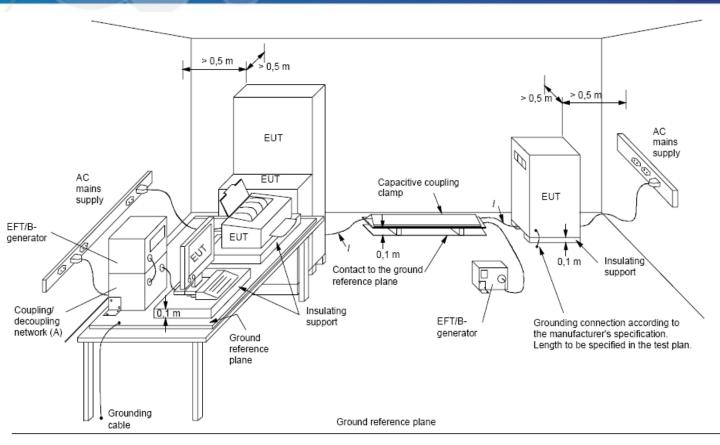


- The test procedure includes:
- the verification of the laboratory reference conditions;
- the preliminary verification of the correct operation of the equipment;
- the execution of the test;
- the evaluation of the test results.



Test setup





IEC 901/04

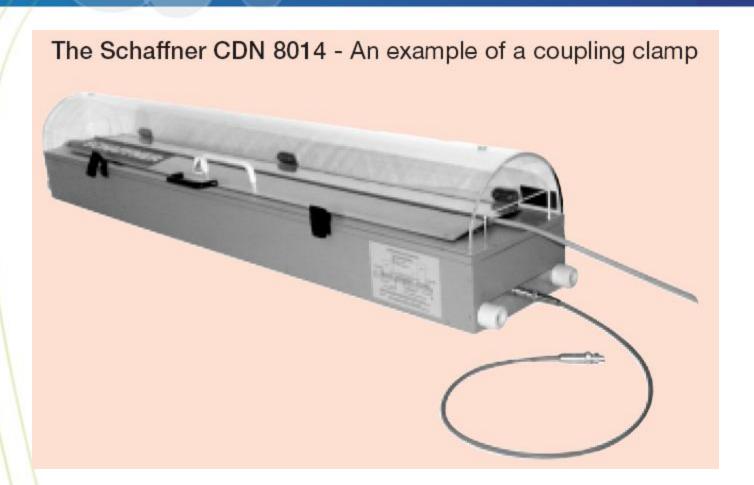
Key

- I length between clamp and the EUT to be tested (should be 0,5 m ± 0,05 m)
- (A) location for supply line coupling
- (B) location for signal lines coupling



Capacitive coupling clamp





Link to the standard IEC 61000-4-4

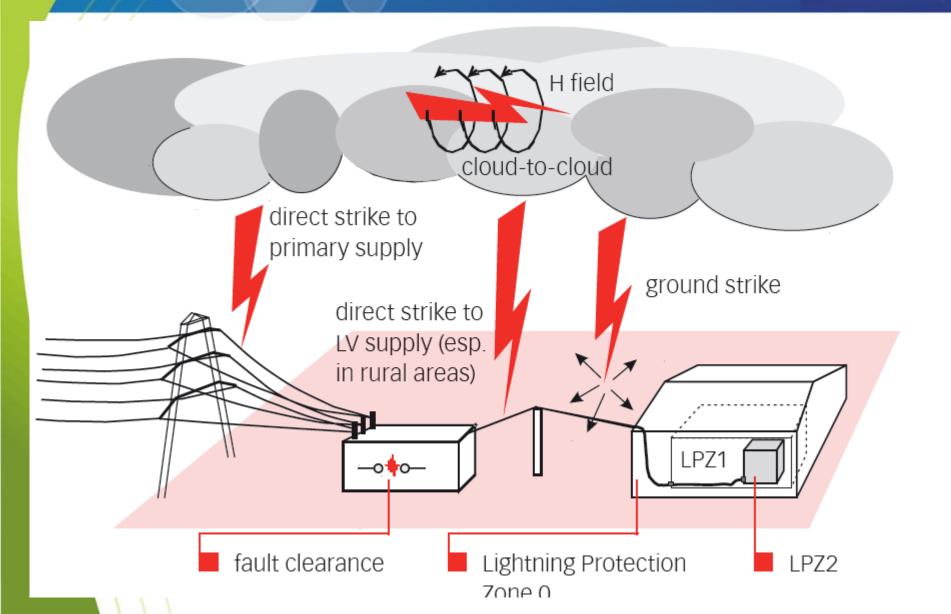




Surge IEC 61000-4-5



The surge phenomenum labs





Surge effects



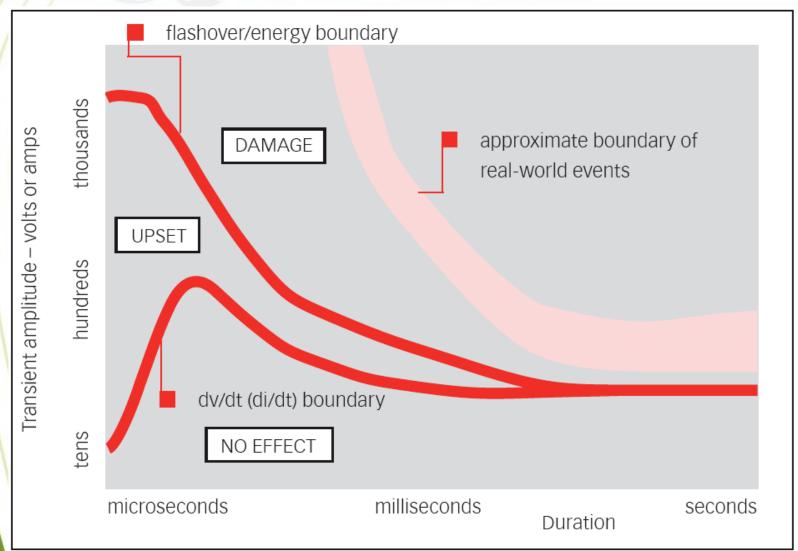
- Surges impinging on electronic equipment may cause
 - hardware damage and complete failure, or in lesser cases, operational upset.
- Below some level dependent on equipment design, no
 - effect is observed.
 - Above this level, a surge may cause the operation of the

39



surge parameters vs equipments effects







Surge tests (IEC 61000-4-5)



Purpose of test:

 Evaluation the immunity of a device across shock waves caused by transient voltages induced by the residual or lightning impulse

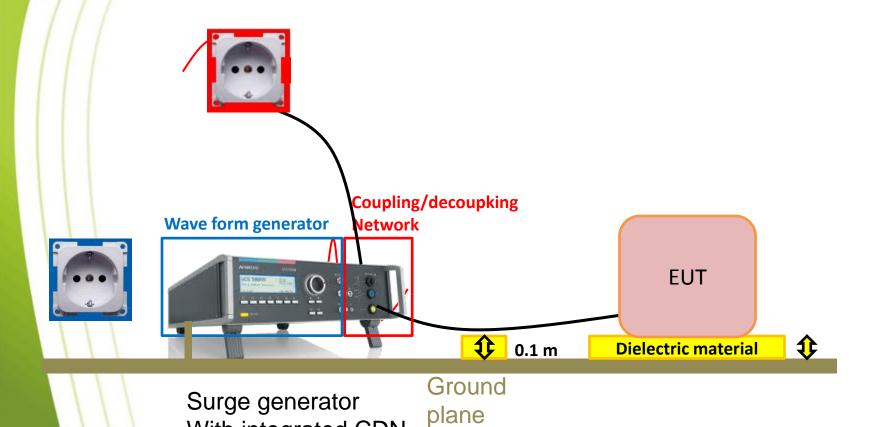
Materials needed:

- ✓ Surge wave generator (1.2 / 50 microseconds),
- Decoupling/coupling network (internal or external)
- Ground plane



Surge immunity – IEC 61000-4-5



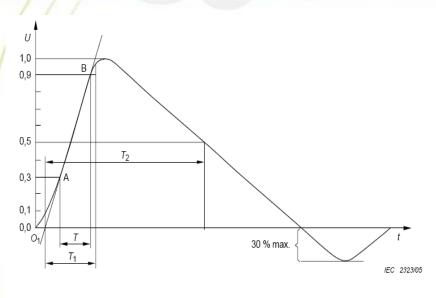


With integrated CDN



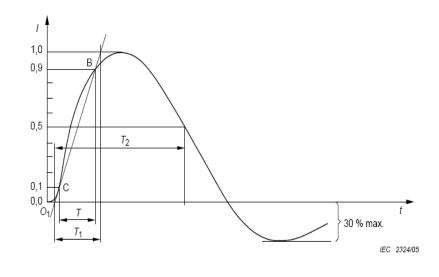
Surge Waveform, 1.2/50 µs





Front time: $T_1 = 1,67 \times T = 1,2 \text{ µs} \pm 30 \text{ %}$ Time to half-value: $T_2 = 50 \text{ µs} \pm 20 \text{ %}$.

Waveform of **open-circuit voltage (1,2/50 µs)** at the output of the generator with no CDN connected (waveform definition according to IEC 60060-1)



Front time: Time to half-value:

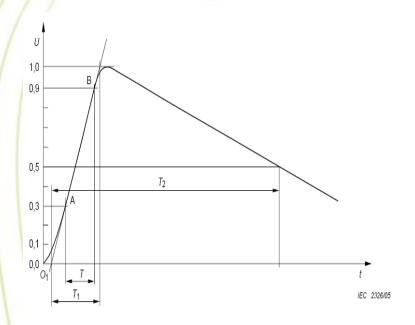
 $T_1 = 1,25 \times T = 8 \mu s \pm 20 \%$ $T_2 = 20 \mu s \pm 20 \%$

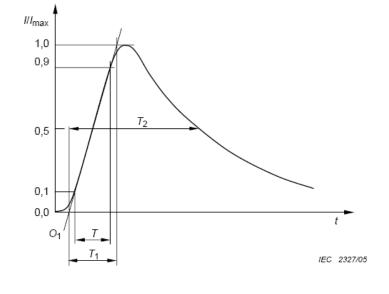
Waveform of **short-circuit current (8/20 µs)** at the output of the generator with no CDN connected (waveform definition according to IEC 60060-1)



Surge Waveform, 10/700 µs







Front time: $T_1 = 1,67 \times T = 10 \text{ µs} \pm 30 \text{ %}$ Time to half-value: $T_2 = 700 \text{ µs} \pm 20 \text{ %}$. Front time: $T_1 = 1,25 \times T = 5 \text{ µs } \pm 20 \text{ %}$ Time to half-value: $T_2 = 320 \text{ µs } \pm 20 \text{ %}$.

Waveform of open-circuit voltage (10/700 µs) (waveform definition according to ITU-T K series and IEC 60060-1)

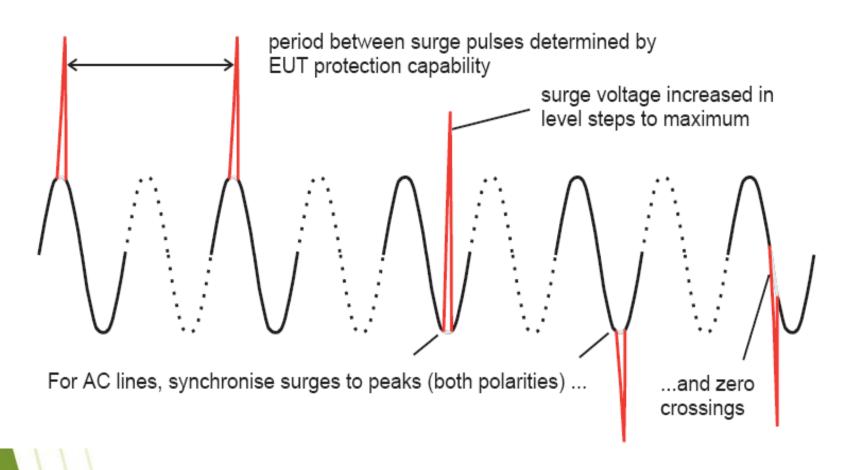
Waveform of the 5/320 µs **short-circuit current** waveform (definition according to **ITU-T K series** and IEC 60060-1)



Surge application



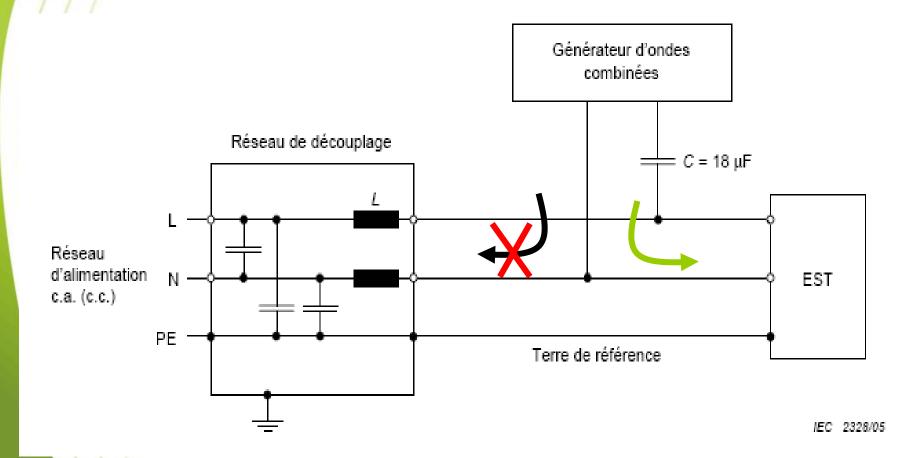
Surge application





Role of CDN







Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

Performance Criteria B – 'Temporary degradation which is self-

recoverable'

Performance Criteria C – 'Temporary degradation which requires

operator intervention'

Performance Criteria D – 'Loss of function which is not recoverable'



Test levels



Level	Open-circuit test voltage ±10 %		
	kV		
1	0,5		
2	1,0		
3	2,0		
4	4,0		
Х	Special		

NOTE X can be any level, above, below or in between the other levels. This level can be specified in the product standard.



Standards calls



Standard	Scope	ESD	EFT-burst	Surge	
IEC/EN 61000-6-1: 2001	Residential, commercial & light industrial generic	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power > 10 m, signal and functional earth > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC power input; 0.5 kV L-L & L-E DC power > 10 m, to IEC/EN 61000-4-5	
IEC/EN 61000-6-2: 2005	Industrial generic	4 kV contact, 8 kV air to IEC/EN 61000-4-2	2 kV AC power, DC power > 3 m, 1 kV signal and functional earth > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC power; 0.5 kV L-L & L-E DC power connected to a distribution network; 1 kV L-E signal > 30 m, to IEC/EN 61000-4-5	
EN 55014-2: 1997 + A1: 2001	Household appliances etc.	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power, signal and control > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC mains, to IEC/EN 61000-4-5	
EN 55020: 2002	Broadcast receivers etc.	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power to IEC/EN 61000-4-4	Not required	
EN 55024: 1998	Information technology equip- ment	4 kV contact, 8 kV air to IEC/EN 61000-4-2	1 kV AC power, 0.5 kV DC power, signal and telecom > 3 m to IEC/EN 61000-4-4	1 kV L-L, 2 kV L-E on AC mains, 0.5 kV L-E on DC power with outdoor cables, to IEC/EN 61000-4-5; 1.5 kV 10/700 µs on signal/telecom ports with outdoor cables, to ITU-T K recs.	



Surge application



- Differential mode and common mode
- In + and polarity
- Number of pulses: 5 (for each polarity)
- Phase angles 0 °, 90 ° and 270 °
- Test levels and intermediate levels



Surge Procedure

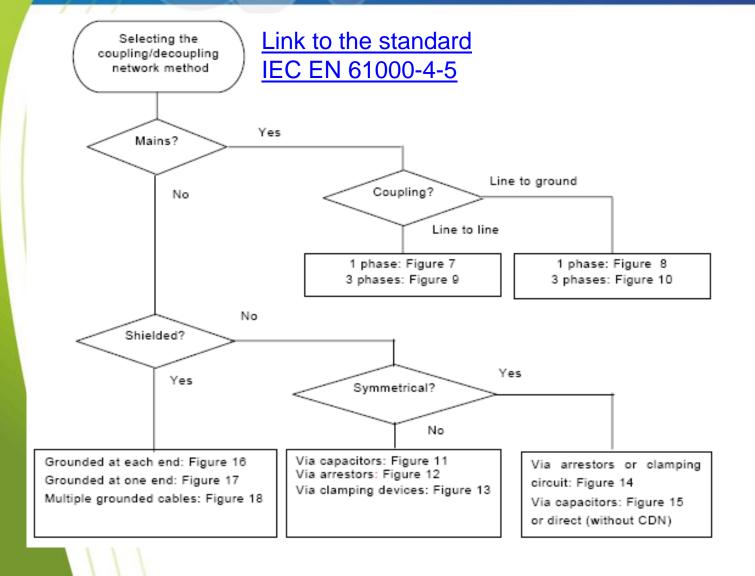


- Apply at least five positive and five negative surges at
 - each coupling point
- Wait for at least a minute between applying each surge, to allow time for any protection devices to recover
- For ac mains,
 - Apply the surges line to line (three combinations for 3-phase delta, six for 3-phase star, one for single phase) and line to



Choice of coupling devices









Comparision between transient tests





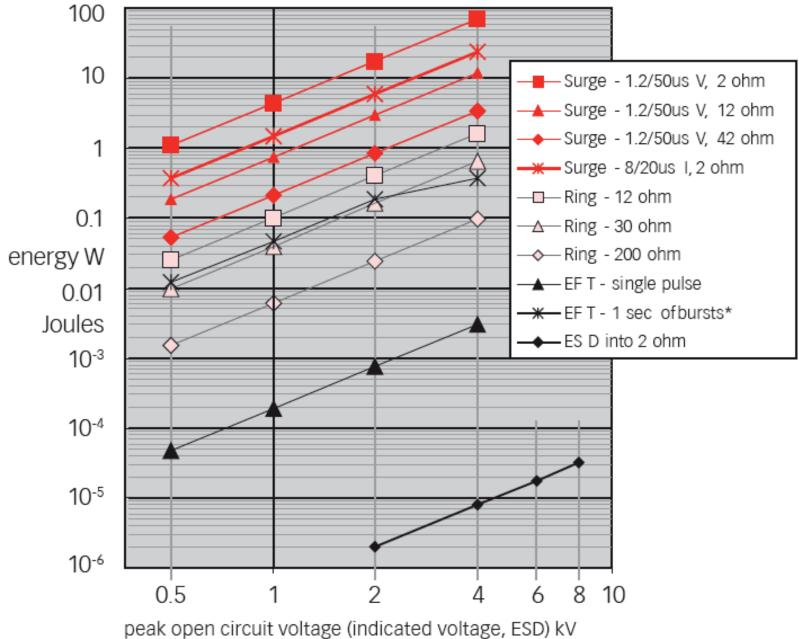
The "energy measure" of a given waveform can be

desc
$$W = \frac{1}{R} \cdot \int_{0}^{T} \left(\frac{V(t)}{2}\right)^{2} dt$$
 $W = R \cdot \int_{0}^{T} \left(\frac{I(t)}{2}\right)^{2} dt$



- Surge test is more energetic than ESD and EFT
 - EFT: waveform magnitude in ns







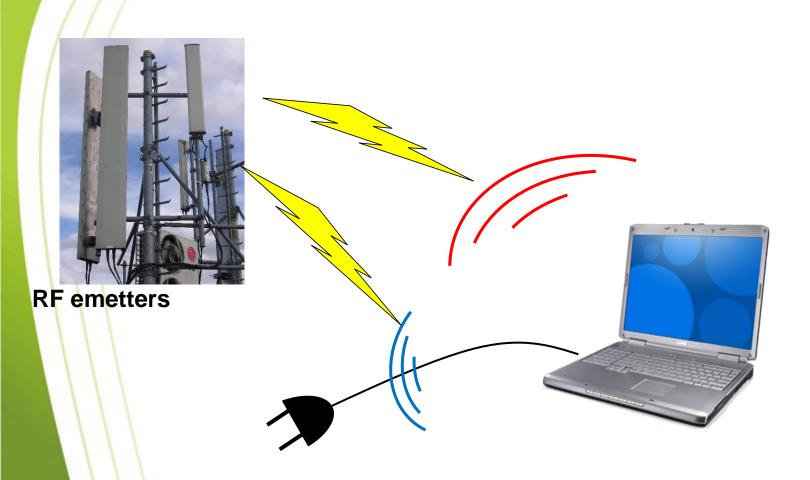


Immunity tests

2 – LF and RF phenomena



RF coupling phenomenum bs







Radiated immunity IEC 61000-4-3



Radiated immunity (IEC 61000-4-3)



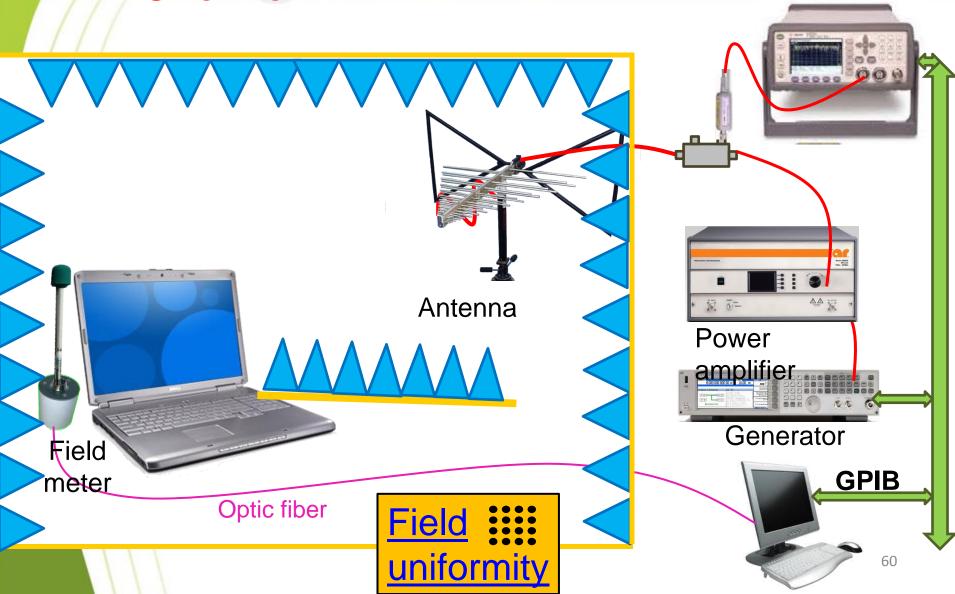
- Test purpose
 - Evaluate the performance of a device submitted to radiated RF field
- Needed instruments:
 - ✓ RF generator
 - ✓ Power amplifier
 - Directional coupler
 - ✓ Power meter

 $\sqrt{\Lambda}$ ntonno(c)



Radiated immunity – IEC 61000-4-3 labs

Overview





Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

Performance Criteria B – 'Temporary degradation which is self-

recoverable'

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Performance Criteria D – 'Loss of function which is not recoverable'



Equipments



- Anechoic chamber: of a size adequate to maintain a uniform field of sufficient dimensions with respect to the equipment under test (EUT). Additional absorbers may be used to damp reflections in chambers which are not fully lined.
- RF signal generator(s) capable of covering the frequency band of interest and of being



Equipments



- Field generating antennas: biconical, log periodic, horn or any other linearly polarized antenna system capable of satisfying frequency requirements.
- An isotropic field sensor with adequate immunity of any
 - head amplifier and optoelectronics to the field strength to be measured, and a fibre optic link to the indicator outside the chamber.
- Associated equipment to record the power



Frequency range



 The tests are normally performed without gaps in the frequency range 80 MHz to 1 000 MHz.

- Test levels related to the protection against RF emissions
 - from digital radio telephones and other RF emitting devices
 - The tests are normally performed in the frequency ranges



Calibration of field



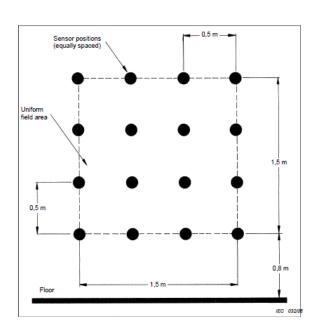
- The purpose of field calibration is to ensure that the uniformity of the field over the test sample is sufficient to ensure the validity of the test results.
- IEC 61000-4-3 uses the concept of a uniform field area,
 - which is a hypothetical vertical plane of the field in which
 - variations are acceptably small.
- A database for setting the required field



Calibration of field



- A full field calibration process should be carried out
 - annually and when changes have been
- The altheis rule by ded into a grid with a grid spacing of 0,5 m (example an 1,5 m × 1,5 m, classure configuration.
- At each frequency, a field is considered unif orm if its magnitude measured at the grid points is within 0/+6 dB of the nominal value for not less than 75 % of all grid points





Calibration of field

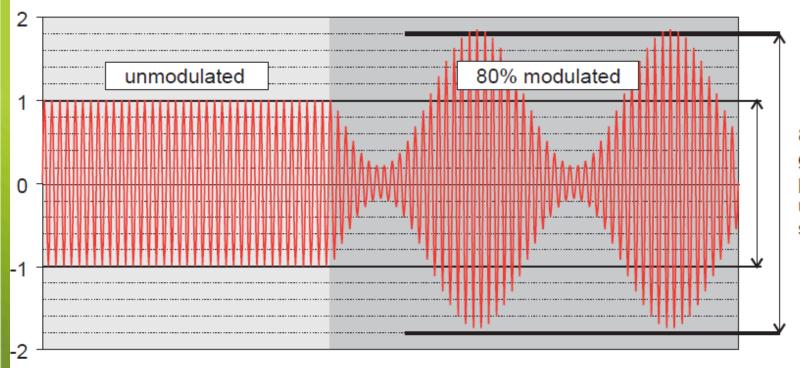


- Calibration is performed at 1.8 times the desired field strength.
- For testing at 10V/m the calibration is run at 18V/m
- The reason of running a test at 1.8x the level is to verify
 - the RF amplifier has the ability to reach the required field when the 80% 1KHz Amplitude Modulation is applied.



AM modulation





80% modulation gives 1.8 times peak level of unmodulated signal



Considerations for equipments choice



- Select an antenna to use.
 - Frequency range
 - Power handling
 - Beam width & gain
- Select the correct amplifier
 - Use calculated power to select the correct amplifier
 - Needs to be selected at the 1dB compression point
 - Calculate power requirements



Performance Criteria for Immunity Tests



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Performance Criteria A – 'Performance within specification limits'

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Test levels



Level	Test field strength	
	V/m	
1	1	
2	3	
3	10	
4	30	
х	Special	

NOTE x is an open test level and the associated field strength may be any value. This level may be given in the product standard.



Standards calls



EN	EN 61000-6-1: 2001	EN 61000-6-2: 2001	EN 301 489-1: v1.4.1	EN 55014-2: 1997 + A1	EN 55020: 2002 + A1 + A2	EN 55024: 1998 + A1 + A2		
Related IEC	IEC 61000-6-1	IEC 61000-6-2	-	CISPR 14-2	CISPR 20	CISPR 24		
Scope	Residential, commercial, light industry generic	Industrial generic	Radio comms equipment: common requirements	Household appliances, electric tools and similar	Broadcast receivers and associated equipment	Information technology equipment		
Test	Requirements							
Radiated RF	3 V/m 80% AM 80-1000 MHz to EN 61000-4-3	10 V/m 80% AM 80-1000 MHz to IEC 61000-4-3, except broadcast bands where level is 3 V/m (2005 version adds tests up to 2.7 GHz)	3 V/m 80% AM 80- 1000 MHz to EN 61000-4-3, with exclusion band, disre- garding narrowband responses	3 V/m 80% AM 80- 1000 MHz to EN 61000-4-3, only category IV appara- tus, and ride on toys with electronics in category III	125 dBmV/m (1.78 V/m) 80% AM 0.15-150 MHz in open stripline, reductions at some frequencies for receivers and VTRs; plus 900 MHz 3 V/m 200 Hz keyed carrier	3 V/m 80% AM ≤80-1000 MHz to EN 61000-4-3, extra spot frequency functional test for TTE		
Conducted RF	3 V rms 80% AM 0.15- 80 MHz to EN 61000-4-6 on AC power and func- tional earth ports, and all signal, control and DC power ports > 3m	10 V rms 80% AM 0.15-80 MHz to ENV 50141, except 47-68 MHz where level is 3 V rms: all ports except signal lines < 3 m	3 V rms 80% AM 0.15- 80 MHz to EN 61000-4-6 on AC power, and sig- nal, telecomm, control and DC power ports > 3 m, with exclusion band, disregarding nar- rowband responses	3 V rms 80% AM 0.15- 80 MHz to EN 61000- 4-6 on AC power ports, 1 V rms on DC and signal ports > 3 m, category IV; extending to 230 MHz for cats. II and III	RF common mode 126 dBmV emf 26-30 MHz, antenna terminal; induced voltages at mains and audio terminals, 0.15- 150 MHz 80% AM up to 130 dBmV emf	3 V rms 80% AM 0.15-80 MHz to EN 61000-4-6 on power and all signal cable ports > 3 m, extra spot frequency functional test for TTE		
LF magnetic field	3 A/m to EN 61000-4-8, susceptible devices only	30 A/m to EN 61000-4-8, susceptible devices only	Not applicable	Not applicable	Not applicable	1 A/m to EN 61000- 4-8, susceptible devices only		



Field strength



The resultant field is computed as folows:

$$e = \frac{\sqrt{30\,p}}{d}$$

- p is the radiated power
- d is the distance between the antenna and the field mesure

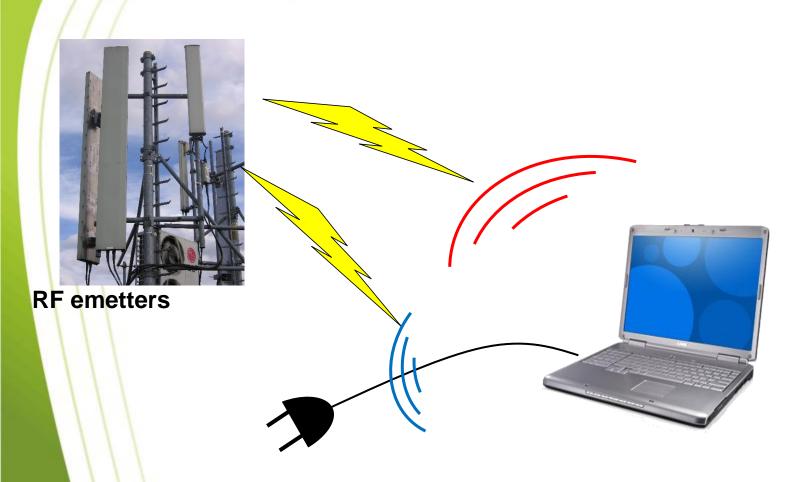




Conducted immunity IEC 61000-4-6



RF coupling phenomenum bs





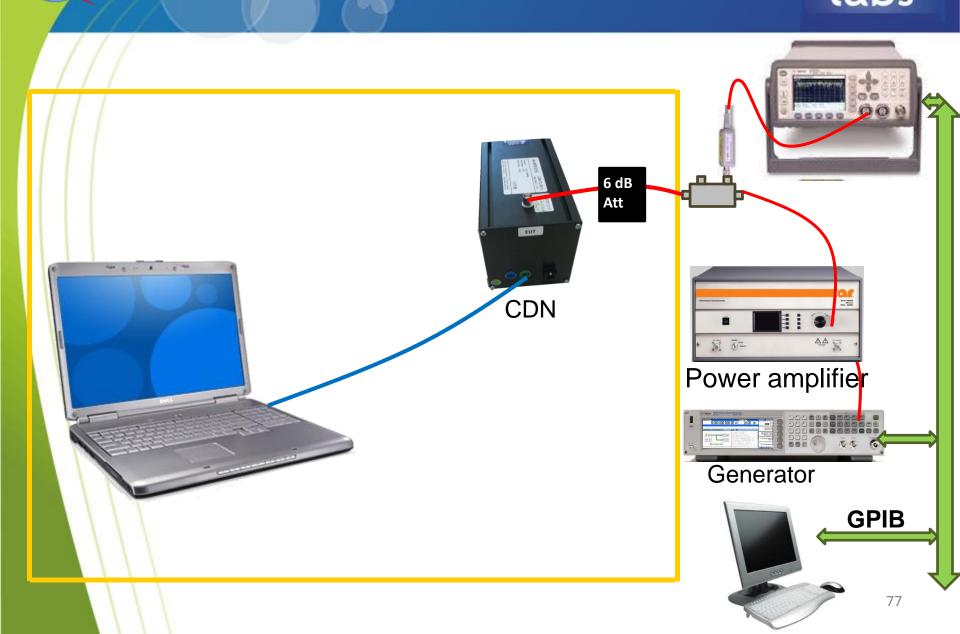
Radiated immunity (IEC 61000-4-3)



- Test purpose
 - Evaluate the performance of a device submitted to conducted electromagnetic field
- Needed instruments:
 - ✓ RF generator
 - ✓ Power amplifier
 - Directional coupler
 - ✓ Dual power meter



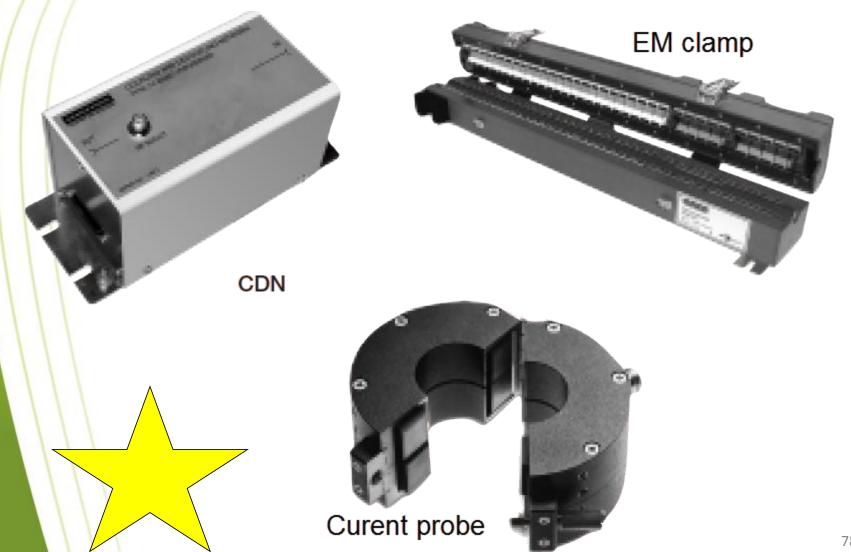
Conducted immunity – IEC 61000-4





Coupling devices







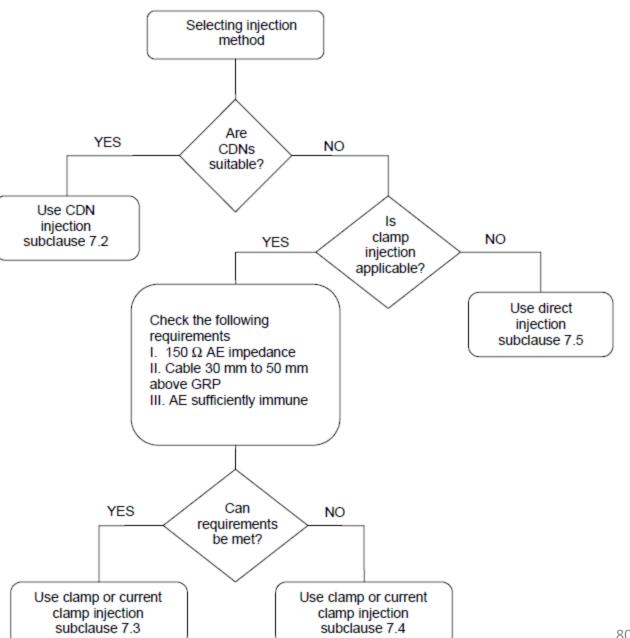
Coupling devices



- Coupling and decoupling devices shall be used for
 - appropriate coupling of the disturbing signal to the various cables connected to the EUT and for preventing applied
 - test signals from affecting other devices, equipment and
 - systems that are not under test.
- The coupling and decoupling devices can be combined



Rules for selecting the **injection** method





Types of CDNs



Тур	Interconnected lines		
M1, M2, M3, M4, M5, M2+M3	Unscreened supply (mains)		
AF2, AF4, AF6, AF8	Unscreened nonbalanced lines		
S1, S2, S9, S25	Screened lines		
T2, T4, T8	Unscreened balanced lines		
RJ11, RJ45	Unscreened data lines		
RJ11/S, RJ45/S, USB	Screened data lines		





Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

Performance Criteria B – 'Temporary degradation which is self-

recoverable'

Performance Criteria C – 'Temporary degradation which requires operator intervention'

Performance Criteria D – 'Loss of function which is not recoverable'



Typical test levels



Table 1 - Test levels

	Voltage level (e.m.f.)		
Level	U ₀	U ₀	
	dB(μV)	V	
1	120	1	
2	130	3	
3	140	10	
X a	Special		



Standards calls



EN	EN 61000-6-1: 2001	EN 61000-6-2: 2001	EN 301 489-1: v1.4.1	EN 55014-2: 1997 + A1	EN 55020: 2002 + A1 + A2	EN 55024: 1998 + A1 + A2	
Related IEC	IEC 61000-6-1	IEC 61000-6-2	-	CISPR 14-2	CISPR 20	CISPR 24	
Scope	Residential, commercial, light industry generic	Industrial generic	Radio comms equipment: common requirements	Household appliances, electric tools and similar	Broadcast receivers and associated equipment	Information technology equipment	
Test	Requirements						
Radiated RF	3 V/m 80% AM 80-1000 MHz to EN 61000-4-3	10 V/m 80% AM 80-1000 MHz to IEC 61000-4-3, except broadcast bands where level is 3 V/m (2005 version adds tests up to 2.7 GHz)	3 V/m 80% AM 80- 1000 MHz to EN 61000-4-3, with exclusion band, disre- garding narrowband responses	3 V/m 80% AM 80- 1000 MHz to EN 61000-4-3, only category IV appara- tus, and ride on toys with electronics in category III	125 dBmV/m (1.78 V/m) 80% AM 0.15-150 MHz in open stripline, reductions at some frequencies for receivers and VTRs; plus 900 MHz 3 V/m 200 Hz keyed carrier	3 V/m 80% AM ≤80-1000 MHz to EN 61000-4-3, extra spot frequency functional test for TTE	
Conducted RF	3 V rms 80% AM 0.15- 80 MHz to EN 61000-4-6 on AC power and func- tional earth ports, and all signal, control and DC power ports > 3m	10 V rms 80% AM 0.15-80 MHz to ENV 50141, except 47-68 MHz where level is 3 V rms: all ports except signal lines < 3 m	3 V rms 80% AM 0.15- 80 MHz to EN 61000-4-6 on AC power, and sig- nal, telecomm, control and DC power ports > 3 m, with exclusion band, disregarding nar- rowband responses	3 V rms 80% AM 0.15- 80 MHz to EN 61000- 4-6 on AC power ports, 1 V rms on DC and signal ports > 3 m, category IV; extending to 230 MHz for cats. II and III	RF common mode 126 dBmV emf 26-30 MHz, antenna terminal; induced voltages at mains and audio terminals, 0.15- 150 MHz 80% AM up to 130 dBmV emf	3 V rms 80% AM 0.15-80 MHz to EN 61000-4-6 on power and all signal cable ports > 3 m, extra spot frequency functional test for TTE	
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Calibrating the injected levels

substitution method

 The power required to give this same stress level is repeated in the actual test.

 For the 150 ohms systems, the required power : vstress/6 or Vstress - 15.6 dB (resistive divider)



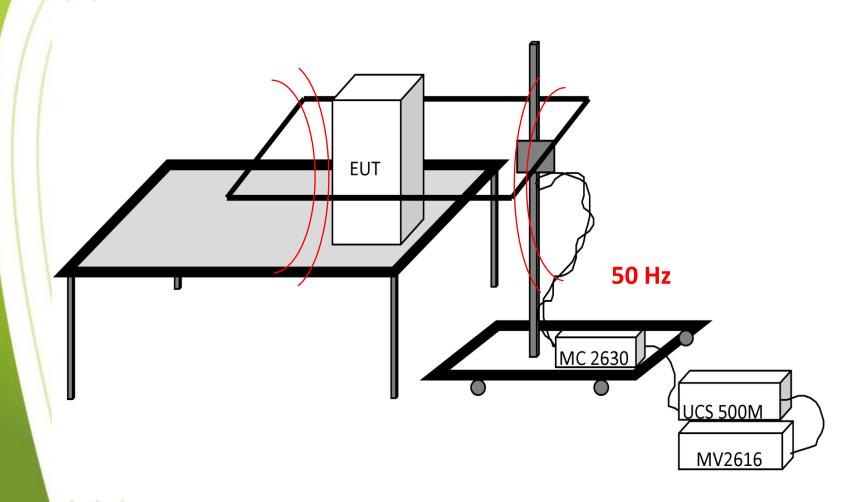


Immunity to magnetic fields IEC 61000-4-8



Magnetic field immunity – IEC 61000-4-8







Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

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recoverable'

Performance Criteria C – 'Temporary degradation which requires operator intervention'

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Standards calls



EN	EN 61000-6-1: 2001	EN 61000-6-2: 2001	EN 301 489-1: v1.4.1	EN 55014-2: 1997 + A1	EN 55020: 2002 + A1 + A2	EN 55024: 1998 + A1 + A2
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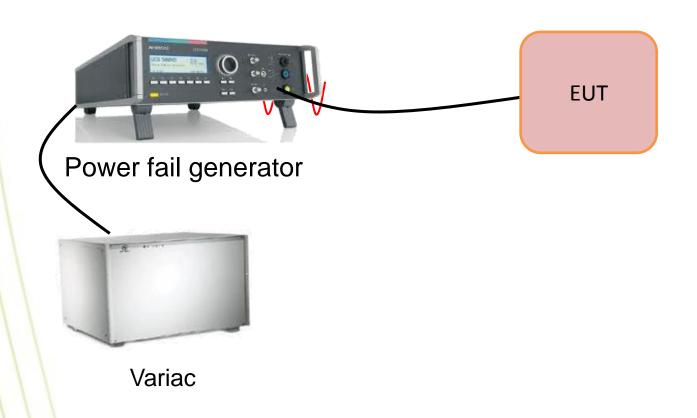




Immunity to voltage dips and short interruptions IEC 61000-4-11



Voltage dips and short interruptions IEC 61000-4-11





Performance Criteria for Immunity Tests



Results of immunity tests are classified into four categories:

Performance Criteria A – 'Performance within specification limits'

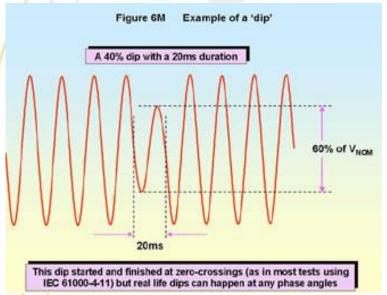
Performance Criteria B – 'Temporary degradation which is self-

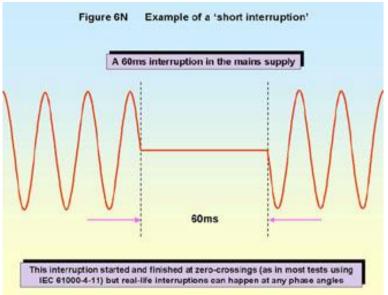
recoverable'

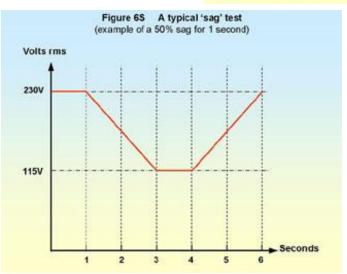
Performance Criteria C – 'Temporary degradation which requires operator intervention'

Performance Criteria D – 'Loss of function which is not recoverable'

Voltage dips and short interruptions EN 61000-4-11 Overview











Emission tests





Emission CISPR 22 / EN 55022



ITE functionnality



An ITE is able to perform:

- Receive data from an external source;
- ✓ Perform treatments
- ✓ Provide a result



Equipements Classes (1)



- The class B ITE is intended primarily for use in a residential area and may include:
 - ✓ the devices having no fixed location of use, such as portable battery powered or batteries incorporated;
 - the telecommunication terminal equipment supplied by a telecommunications network;
 - personal computers and auxiliary devices connected to them.



Equipements Classes(2)



- Class A consists of all other ATI complying with the limits of disturbance of class
 A but not those of class B.
- Can be used in commercial or industrial environment.





Conducted emissions CISPR22/EN 55022



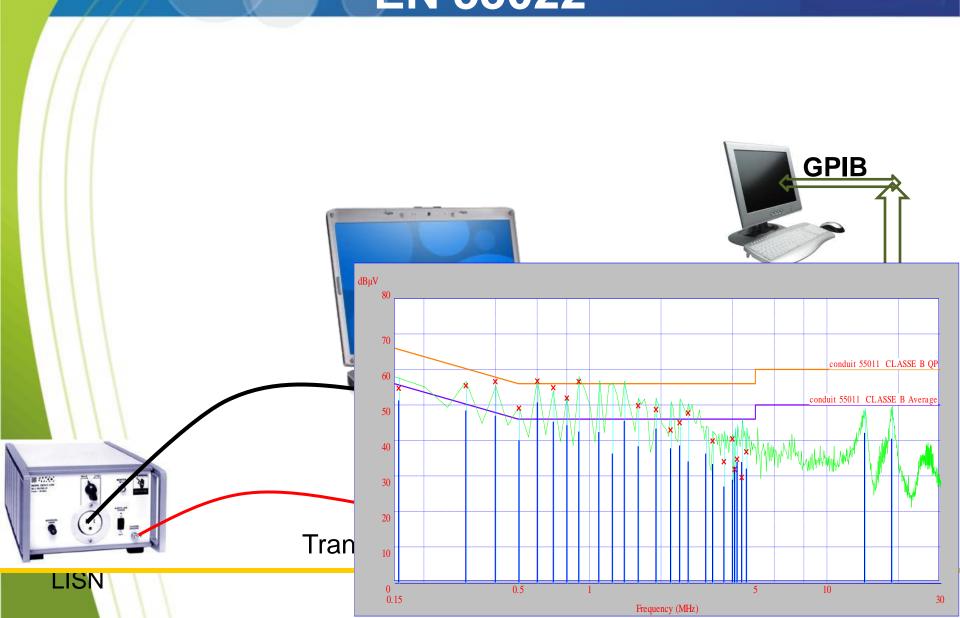
Required equipments



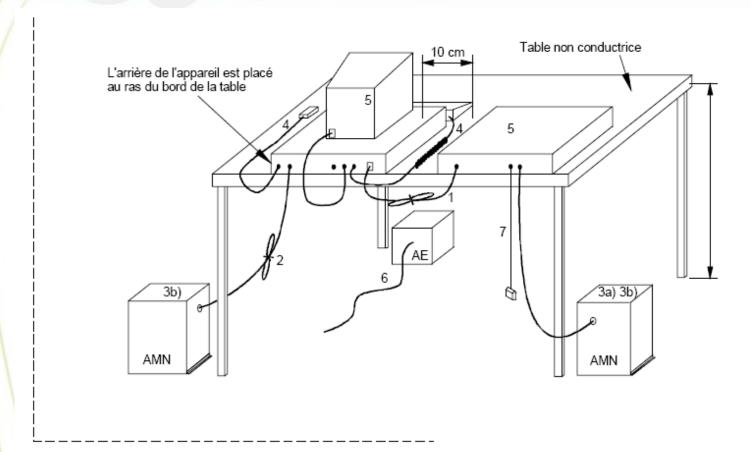
- For power supply lines:
 - ✓ LISN (Lines Impedance Stabilisation Network)
- For data lines:
 - ISN (Impedance Stabilisation Network)
- Transient limiter
- EMI receiver or spectrum analyser
- EMI software



Conducted emission - CISPR22 EN 55022



Conducted emission test setupos



AMN = Réseau fictif

AE = Appareil auxiliaire

EUT = Appareil à l'essai

RSI = Réseau de stabilisation d'impédance



Conducted emissions



Measurement of conducted electromagnetic disturbances must be made:

- by means of a measuring receiver
- with a peak detector
- in the frequency range 9 kHz to 30 MHz.



Conducted limits

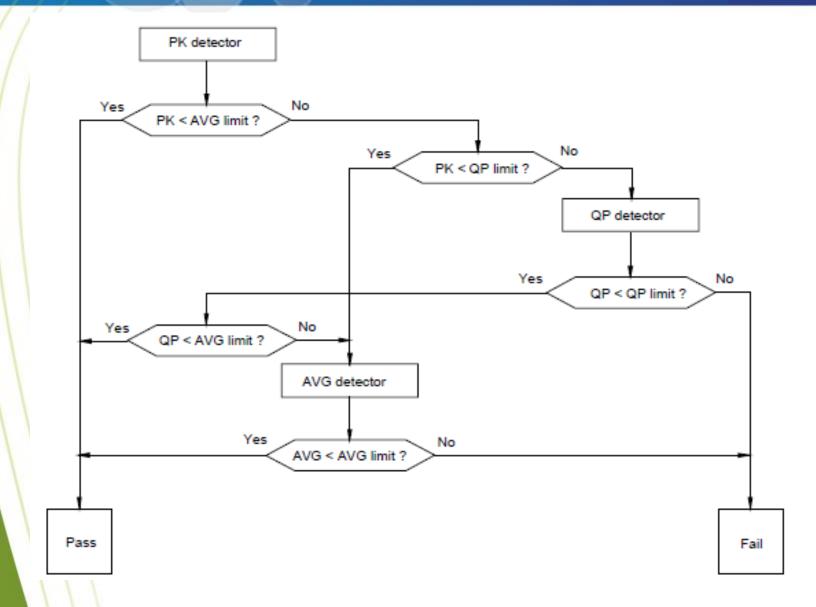


- The EUT shall respect the limits of Tables 1 and 2 which include limits on the mean value and limits on quasi-peak value
- A receiver is used to average value detection and a quasi-peak detector



Decision tree



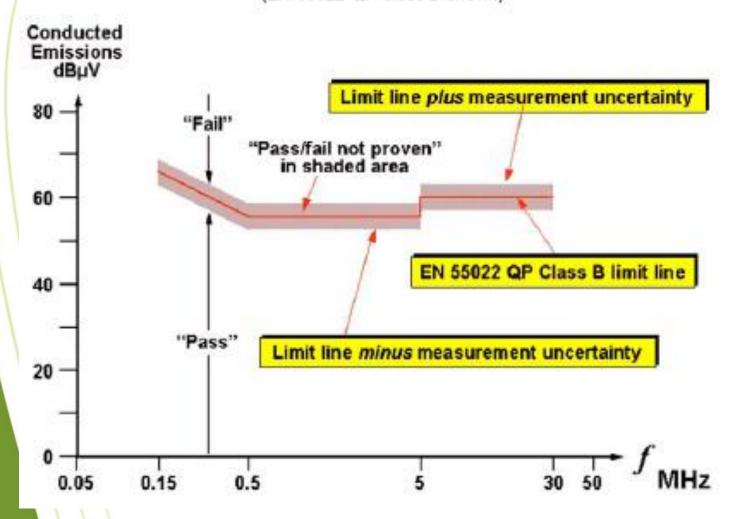




Emissison thresholds



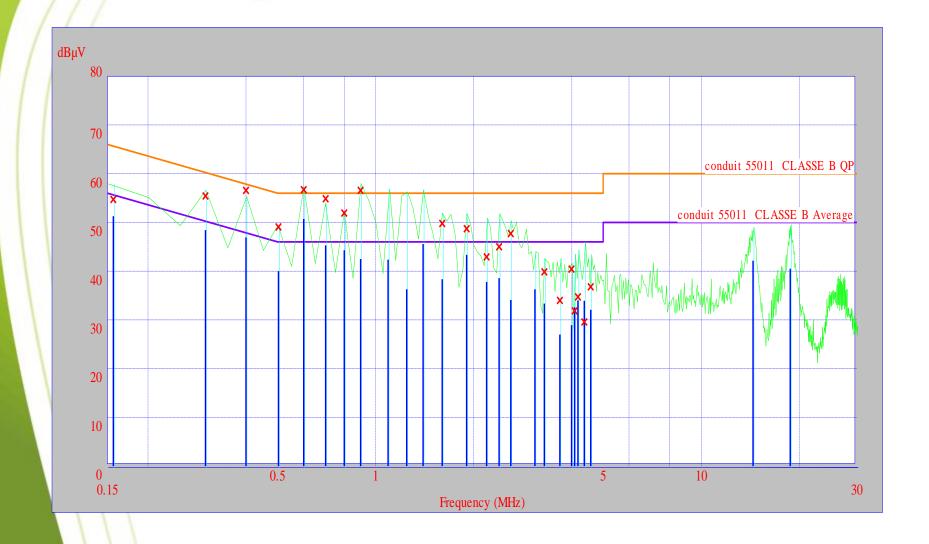
Example of reporting mesurement uncertainty (EN 55022 QP Class B shown)





Measure









Radiated emissions CISPR22/EN 55022



Required equipments

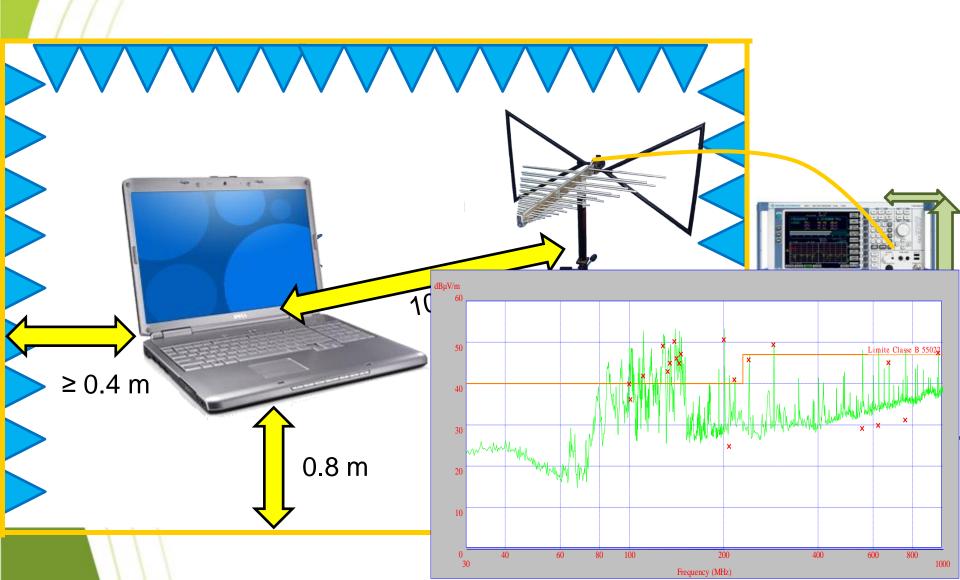


- Receiving antennas
- EMI receiver or spectrum analyser
- EMI software

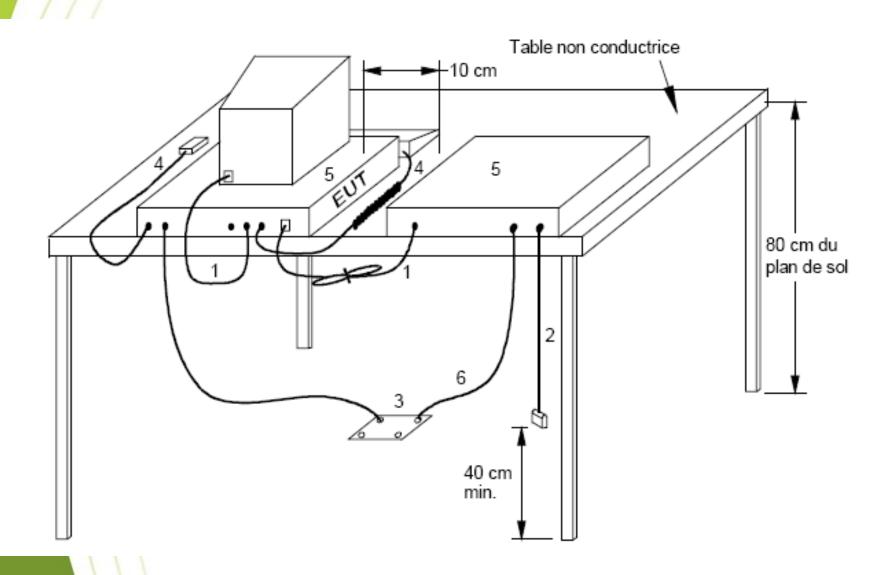


Radiated emission - CISPR22/EN 55022





Test setup for radiated emission





Radiated emission



The measurement of radiated electromagnetic disturbances must be performed by means of a measuring receiver equipped with a quasi-peak detector in the frequency range 30 MHz to 1 GHz or 6 GHz.

A receiving antenna, associated with a



Radiated EM field measure

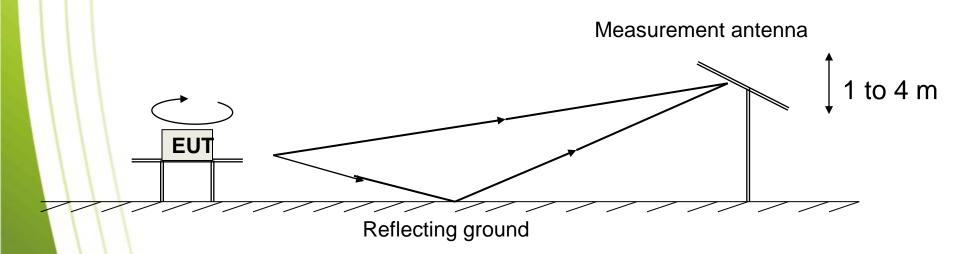
Peak measure to determine the most perturbing condition

 Determining antenna polarisation that most generate
 disturbances

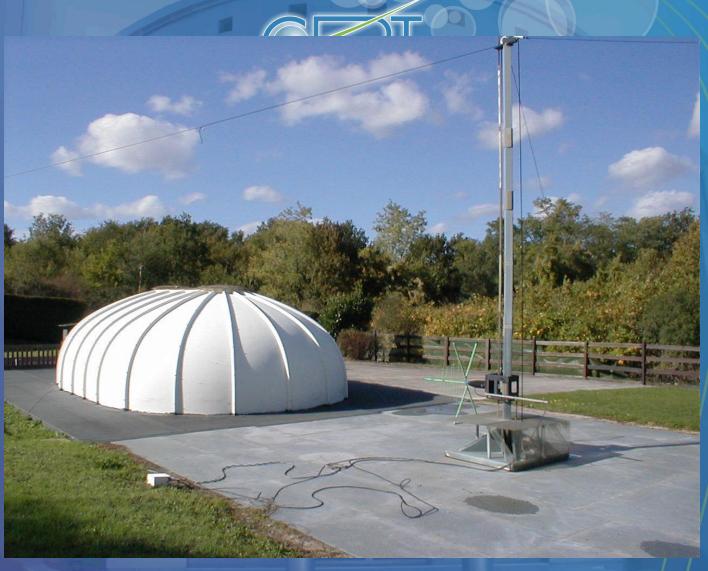
For every frequency :

madiated field measurement





Open area test site

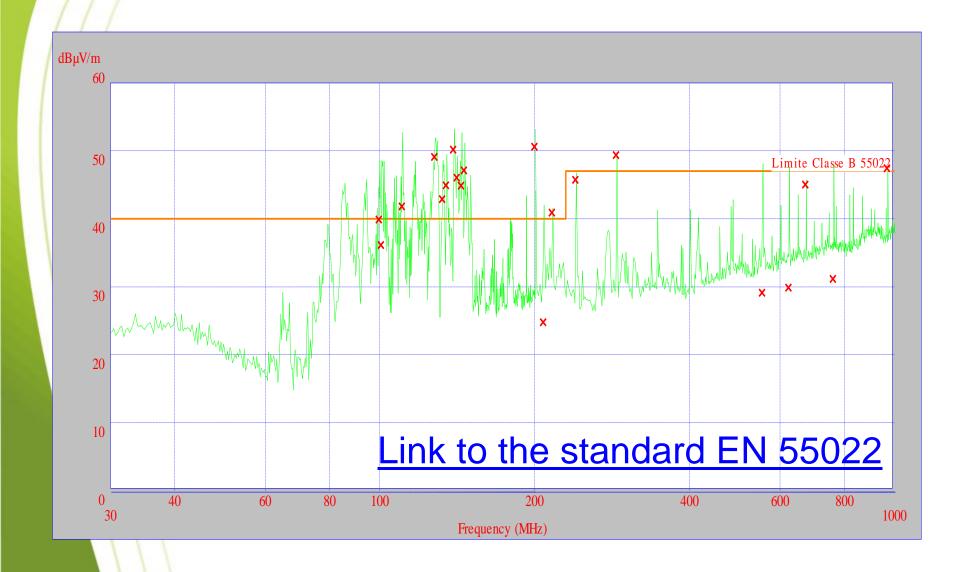


Site de mesure en espace libre



Measure









Harmonics emission IEC 61000-3-2



Harmonics emission



Causes

They are generated by devices that consume non-

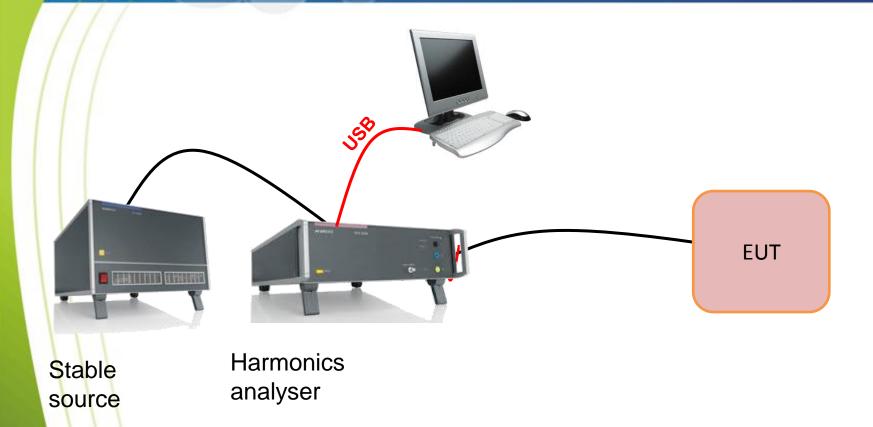
sinusoidal current, such as fluorescent lighting or power

supplies (equipment components nonlinear diodes,

thyristors ...)

Thermonics emission – IEC 61000-3-2

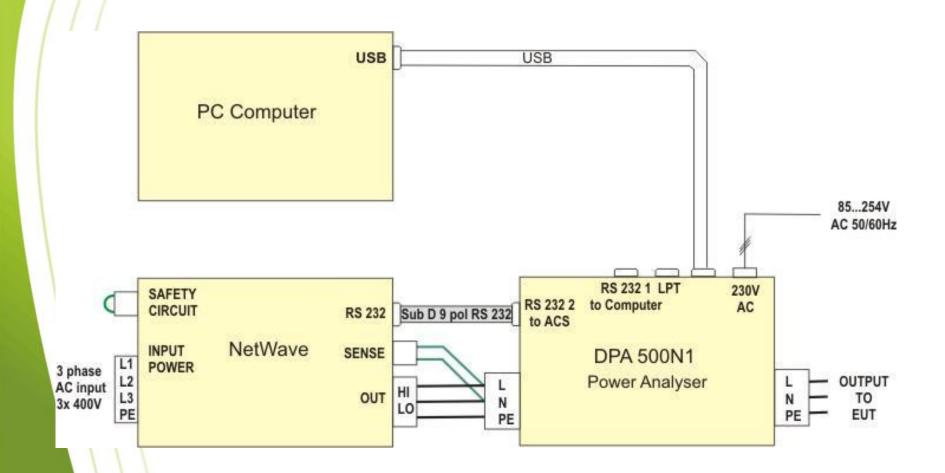






DPA connection



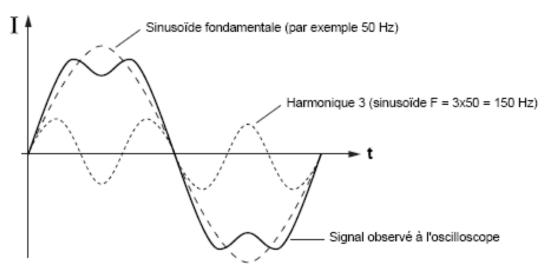




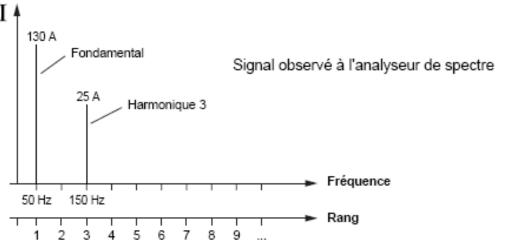
Spectral effects



Temporal



Spectral





Time vs frequency representation







Test classes



There are 4 different classes in the EN 61000-3-2 that

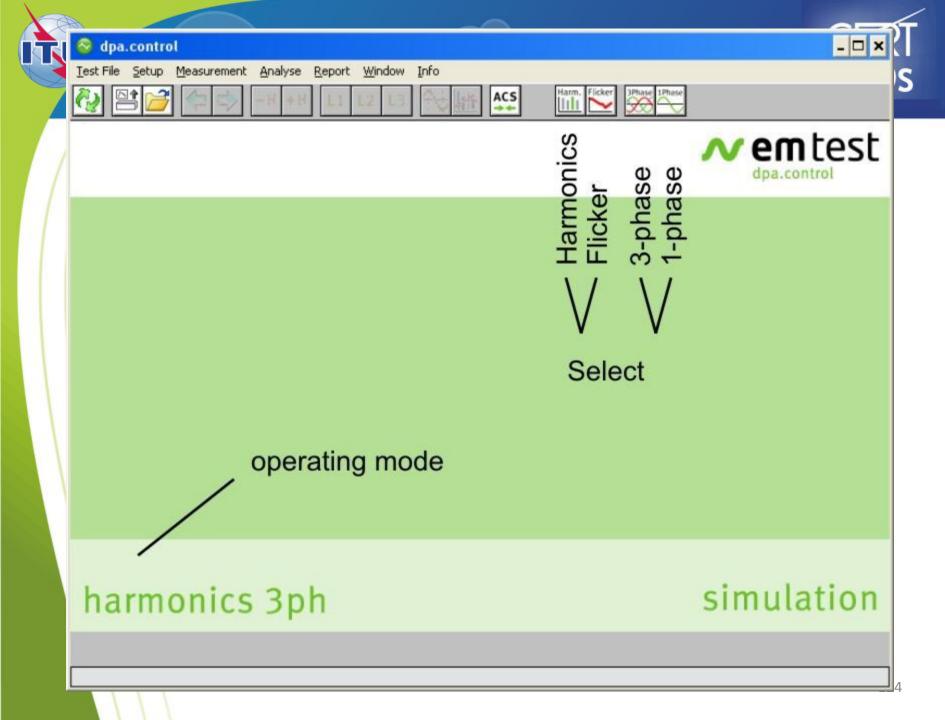
have different limit values:

Class A: Balanced 3-phase equipment,

household appliances excluding equipment identified as class D, tools, excluding portable tools, dimmers

for incandescent lamps, audio equipment, and all

other equipment, except that stated in one





Test procedure



- 1. Select the correct test observation period (Table 6.1) of the EUT (min. 10s)
- 2. Enter the following data (only Class C and D), if available
 - Class D: Max. Power or Class C: Maximum Fund. current and Max Power Factor
- 1. Start the measuring
- 2. Upload the data to the computer
- 3. Select the Class A...D
- 4. Start the evaluation



Data flow



- The DPA measures simultaneously on all 2 or 6 input
 channels, carries out the Fourier transformation in real
 - time
- stores all data on the internal hard disk.
- When measuring fluctuations the system generates approx. 1 Mbyte data per minute on the hard disk. The upload of a 2.5 minute measurement needs less than 20 seconds.

126



Test parameters

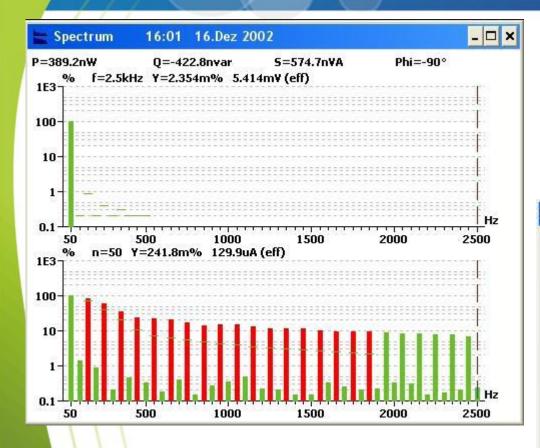


aluation acc. EN/IEC or JIS C 610 Standard	Select class
● EN/IEC 61000-3-2 Ed.3	● Class A <= 150% of the limit
 JIS C 61000-3-2 [Japan] 	C Class B
	C Class C > 25W
Percentage of limits	C Class D
Enable Percent 100	C Class X Show Table
Japan Parameters Vnom: 100.00 V ©	1 Ph. 💌 3 Ph. Delta 💢 Household luminaire
Maximum smoothed data Power: 23.70 W Fui	nd. Current: 0.106 A Power Factor: 0.557
<u>E</u> valua	etion E <u>n</u> d



Test result





Limit values are indicated and harmonics exceeding the specified limit are marked in red colour.

Check harmonics 240 [e	exception or	dd 2139]
Harmonic(s) >150% :	15	First Harmonic
Average >100%:	None	First Harmonic
Check odd harmonics 21	39	
Partial >Partial limit :	None	First Dataset
Harmonic(s) >150% :	23	First Harmonic
Average >150%:	None	First Harmonic
Test result		
EUT: FAIL P	ower source	e: PASS





Flickers emission IEC 61000-3-3



Flicker

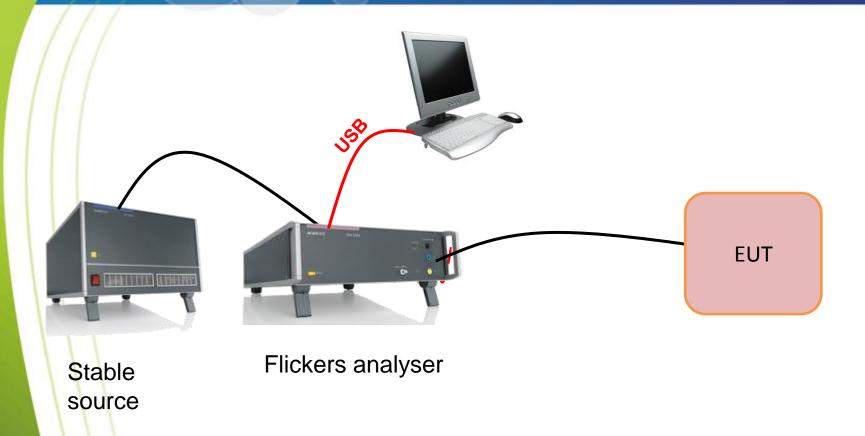


- Flicker standards are imposed to limit voltage variations
 - caused by loads connected to the supply network that
 - would cause lights connected at the same circuit to flicker.

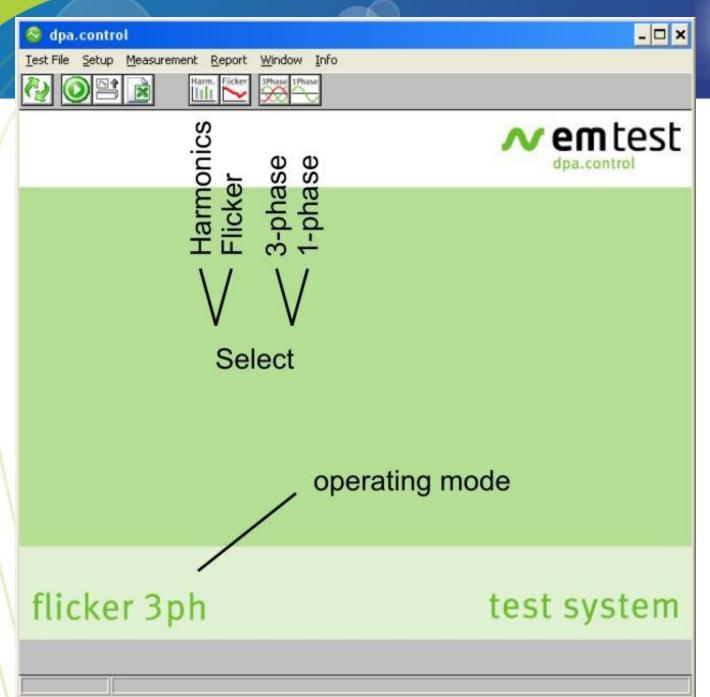
For device single phase up to 16A the standard

Fickers emission – IEC 61000-3-3













Flickers test



lickerme 230V		C 120V / 60Hz	AC Source Use current ACS setting 230V/50H
Standar	d		1.4
EN/IE	C 61000-3-3 Ed.2	2008 (replace A1:20	01/A2:2005)
Speci	al	0.000.0	
Paramet	:er	Test Time	Test Procedure
Pst	Limit Enable	Measurement tim	• Acc. EN/IEC 61000-3-3 • Acc. EN/IEC 51000-3-11
Plt dc	0.65	Dwell time between measurements [s	en Flicker Impedance
dmax dt [s]	4.00	Number of measurement	• Zref (IEC 60725) • Ztest (Isopply >=100A)
	easurement if EUT	is out of limits	

The flicker analysis is based on a standards library including the basic standards but also, and even more important, product-specific Requirements such as hair dryers and vacuum cleaners.

The actual flicker values are continously displayed. A test can be stopped once a limit is exceeded. This could, in case, safe valuable test time.



Flickers parameters



After the flicker measurement the values of dc, dmax, dt are

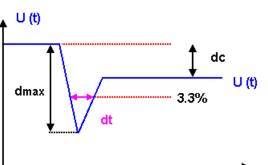
displayed on the screen.

 dc: Relative continuous voltage variation (must be smaller than 3.3%) The dc value is a % value relative to the nominal AC

voltage of 230V AC.

• dmax: Max. rt smaller than value relative

voltage of 23



rariation (must be e dmax value is a % AC



Limits



- The limits shall be applicable to voltage fluctuations and flicker at the supply terminals of the equipment under test:
- The following limits apply:
 - + the value of Pst shall not be greater than 1,0;
 - the value of Plt shall not be greater than 0,65;
 - the value of d(t) during a voltage change shall not exceed 3,3 % for more than 500 ms;
 - the relative steady-state voltage change, dc, shall



Limits

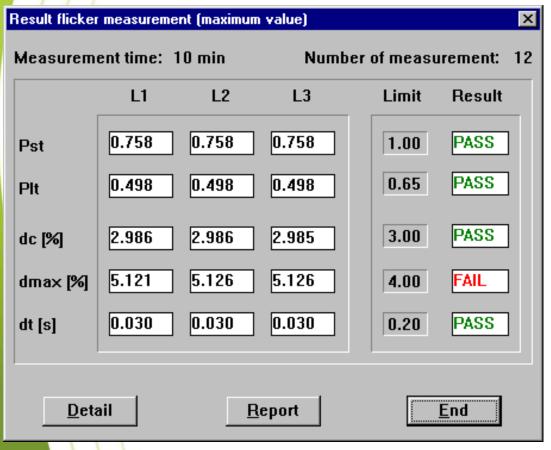


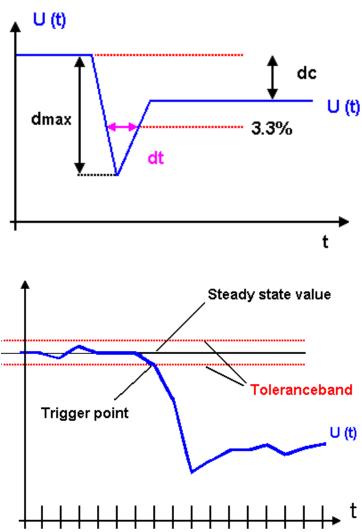
- the maximum relative voltage change dmax, shall not exceed
 - a) 4 % without additional conditions;
 - b) 6 % for equipment which is:
 - switched manually, or
 - switched automatically more frequently than twice per day
 - c) 7 % for equipment which is
 - attended whilst in use
 - switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart



Test results











Example of a product standard

EN 55024





Example of a generic standard

EN 61000-6-1





Example of a test report

<u>Link</u>



Training Course on Conformity and Interoperability,

Tunis-Tunisia, from 14 to 18 December 2015



Speed up your compliance

EMC standards

Presented by: Karim Loukil & Kaïs Siala